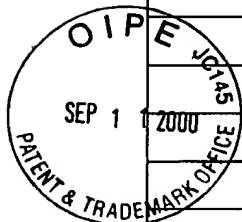


FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))	Attorney Docket No.: GR 97 P 2659 P	Serial No. 09/538,792
	Applicant Vincenzo Scotto Di Carlo et al.	
	Filing Date March 30, 2000	Group Art Unit 2748

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
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		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
<i>970</i>	J	43 32 057 A1	03/30/95	Germany			X
<i>970</i>	K	44 14 968 A1	11/02/95	Germany			X
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>970</i>	O	Euisik Yoon et al.: "An Integrated Mass Flow Sensor with on-Chip CMOS Interface Circuitry", IEEE Transactions on Electron Devices, Vol. 39, No. 6, June 1992, pp. 1376-1385
<i>970</i>	P	S. Middelhoeck et al.: "Silicon sensors", Meas. Sci. Technol. 6 (1995), pp. 1641-1658

EXAMINER <i>[Signature]</i>	DATE CONSIDERED 5/16/02
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EXAMINER. Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (SUBSTITUTE)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(37 CFR 1.98(b))Attorney Docket No.: GR 97 P 2659
Appl. No.Applicant VINCENZO SCOTTO DI CARLO ET
AL.Filing Date March 30, 2000
Group Art Unit

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09/538792
03/30/00

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
<i>ATP</i>	A	4,837,798	06/89	Cohen et al.			
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FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
<i>ATP</i>	J	0 823 809 A2	02/98	Europe			X
	K						
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

<i>ATP</i>		Published International Application No. WO 92/14330 (Lahtinen et al.), dated August 20, 1992;
<i>ATP</i>		Published International Application No. WO 97/33421 (Pepe et al.), dated September 12, 1997;

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.